

**Notice of References Cited**Application/Control No.  
09/886,741Applicant(s)/Patent Under  
Reexamination  
CHAN ET AL.Examiner  
Chris C. ChuArt Unit  
2815

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-20020074669 - A1	06-2002	Watanabe et al.	257/777
	B	US-20020017721 - A1	02-2002	Huang	257/724
	C	US-6376907 - B1	04-2002	Takano et al.	257/704
	D	US-6208525 - B1	03-2001	Imasu et al.	361/783
	E	US-6157080 - A	12-2000	Tamaki et al.	257/738
	F	US-5872051 - A	02-1999	Fallon et al.	438/616
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.